



**Monolithic Bidirectional GaN-Device:
Opportunity and Challenges for Highly Efficient
Design of Power Electronics Converters**

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**Bodo's
Wide Bandgap
Event 2024**

Making WBG Designs Happen

GaN

▼ Introduction

- **Importance of WBG-based Bidirectional Device**
- **Emergence of Monolithic Bidirectional Switch (MBS)/Opportunity and Challenges**

▼ Applications

- **MBS-GaN as an Isolation Switch in Solid State Circuit Breaker (SSCB)**
- **MBS-GaN in Fault-Tolerant Multi-Winding DC-DC Converters**
- **MBS-GaN in Reconfigurable Dual Active Bridge (DAB) Converter**

▼ Conclusion



INTRODUCTION

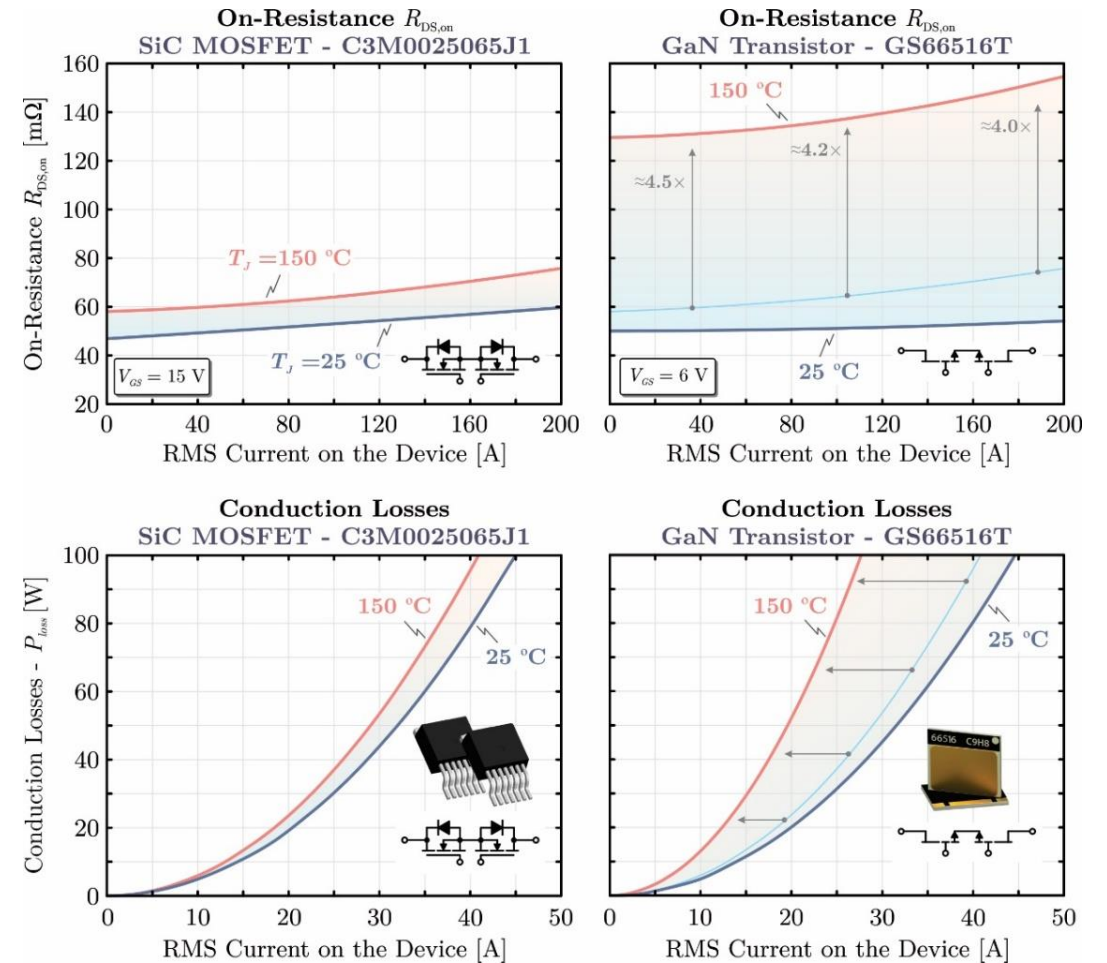
▼ Introduction

► Construction of Bi-Directional FETs Using Discrete Wide Band Gap Devices

- **Features:** Block a stress voltage in both polarities and conduct symmetric current in both directions.
- **Major Applications:** Current-Source Converters, Multilevel Inverters, AC-DC Rectifiers, Resonant/Non-Resonant DC/DC Converters.
- **Typical Configuration:** Common-source/drain configuration with two or four discrete devices with different no of gate drivers.

Challenges posed by Discrete GaN-HEMTs

- Higher conduction losses compared to SiC MOSFETs (4.0 times higher)
- GaN HEMTs are highly sensitive to Junction Temperature and circuit parasitics.



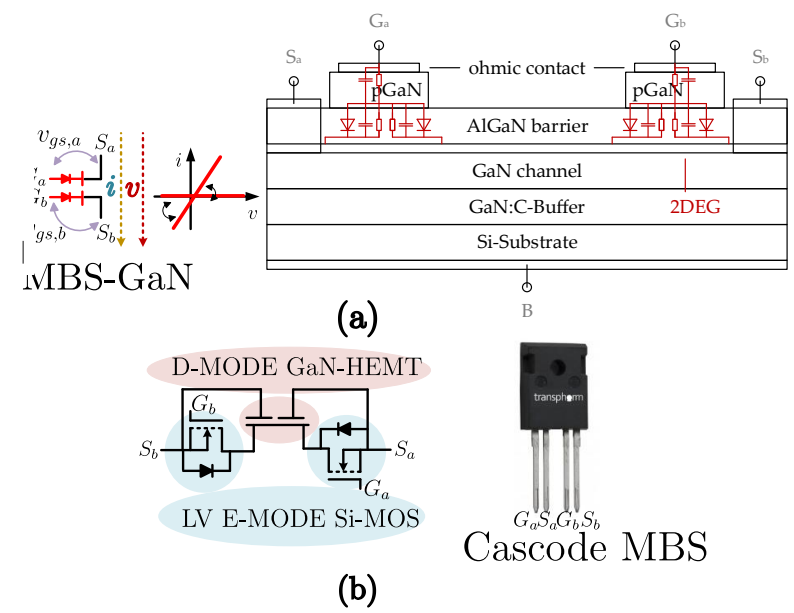
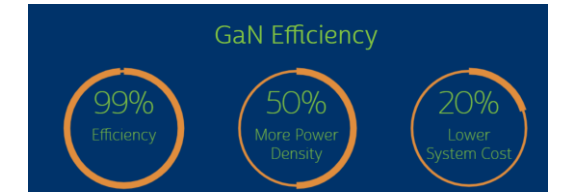
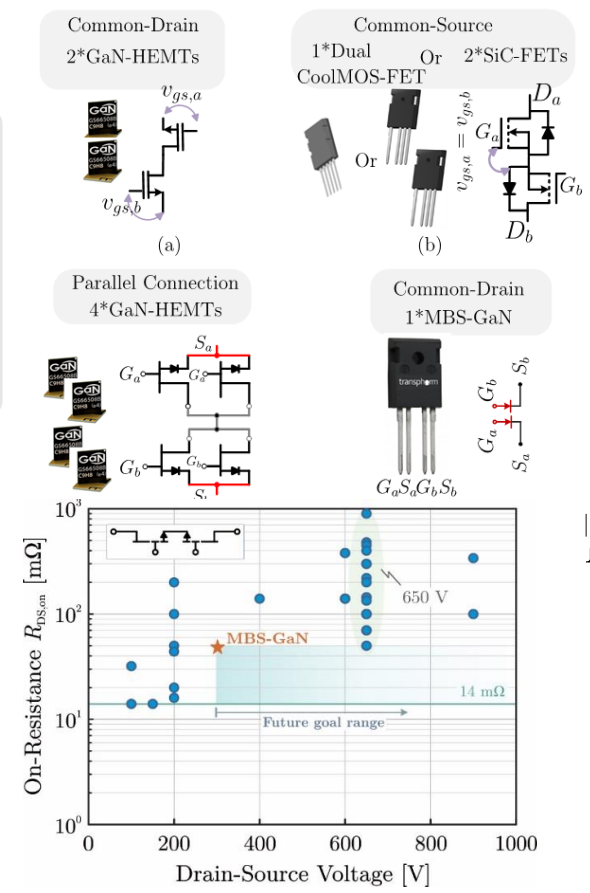
Introduction

► Monolithic Bidirectional Switch (MBS)-GaN MBS Opportunities:

- ✓ Four-Pin **Common-Drain-Based**
- ✓ Lateral **2DEG-based** design (+650 V **Source-Source Voltage**)
- ✓ **Two controllable gates**
- ✓ **Low ON-state parasitic resistance/capacitors.**
- ✓ Easier implementation for better **power layout.**

MBS Challenges:

- ❖ **Two gate driver/isolated dc supplies.**
- ❖ **Termination process** for back-gating effect and gate leakage current.
- ❖ **Short-circuit/thermal management behavior.**
- ❖ Large **reverse recovery charge** in **hard switching application (in cascode version).**
- ❖ Lack of **Kelvin-Source Pins.**



MBS alternative of Bi-GaN-HEMT constructed based on (a) a lateral normally-OFF GaN-based fabrication (**Panasonic/Infineon Device +650V/140 mili Ohm**), (b) with a cascode Si/GaN fashion (**Transphorm Device +650V/70 mili Ohm**)

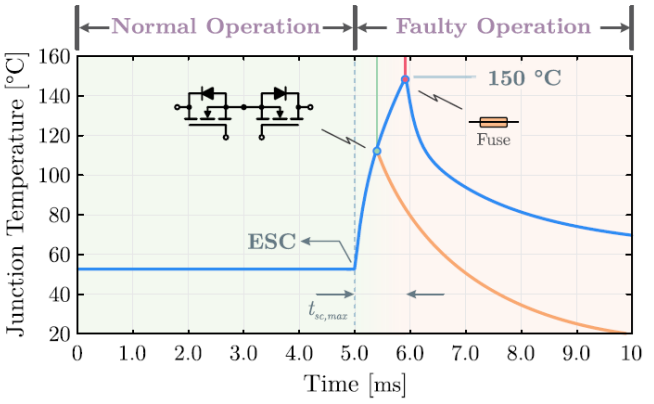
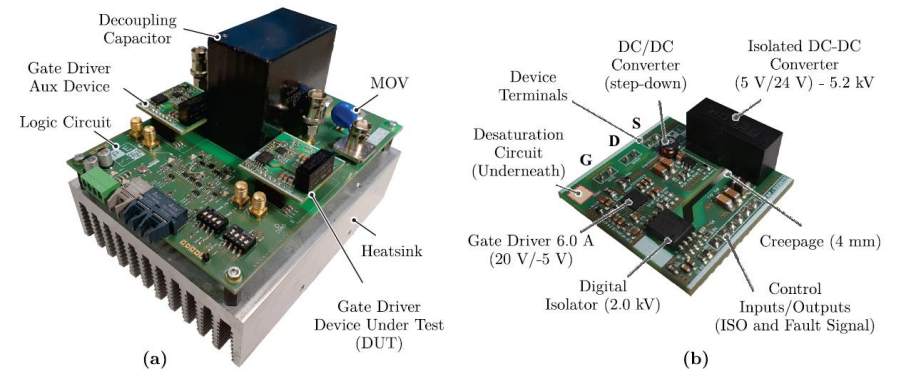
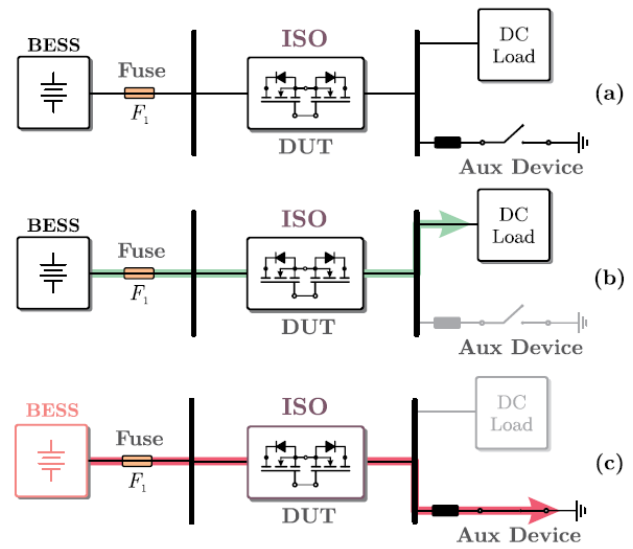


APPLICATIONS

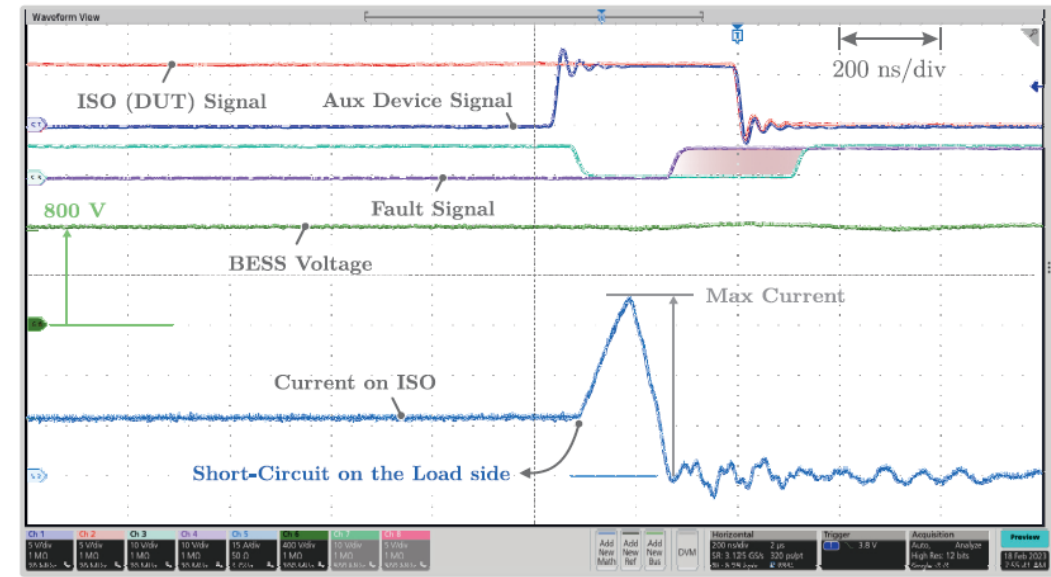
BiDIRECTIONAL DEVICES ISOLATION SWITCH

► Experimental Verification of the Protection Scheme

- ❑ Implemented DC Network to validate the effectiveness of the protection scheme:
- a) The main connections and elements are exhibited;
- b) Normal operation of the system is highlighted by the power flow from the BESS to the DC load [Green Path]. BESS feeding the DC Load.
- c) True short-circuit is applied to the BESS during the normal operation [FUL].



SSB-protection scheme is configured to trip in the first 200 ns, while a slow-blow fuse is placed as the latest resource.



BiDIRECTIONAL DEVICES ISOLATION SWITCH

► Application in Fault-Tolerant MWT DC-DC Converter

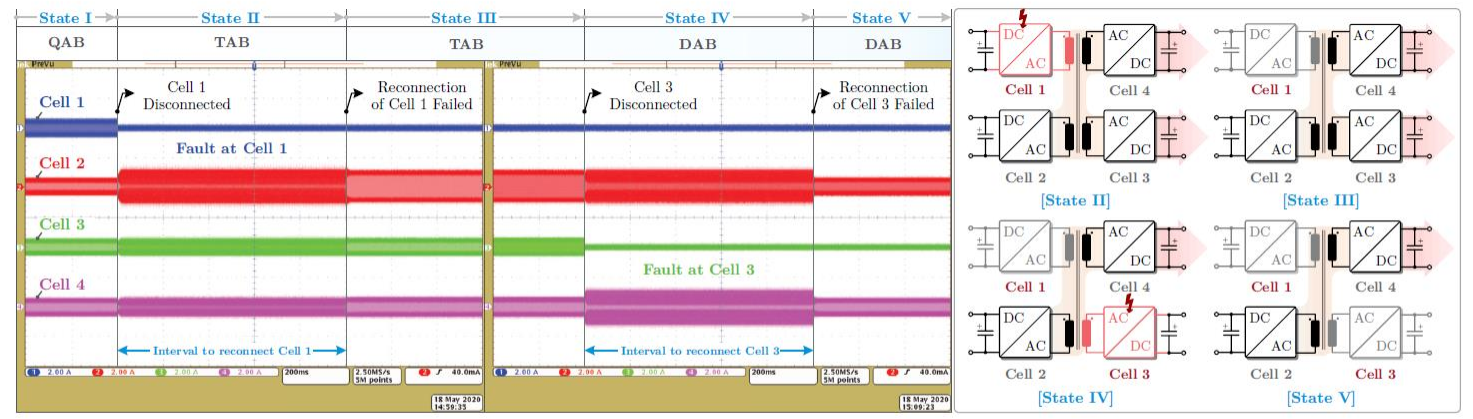
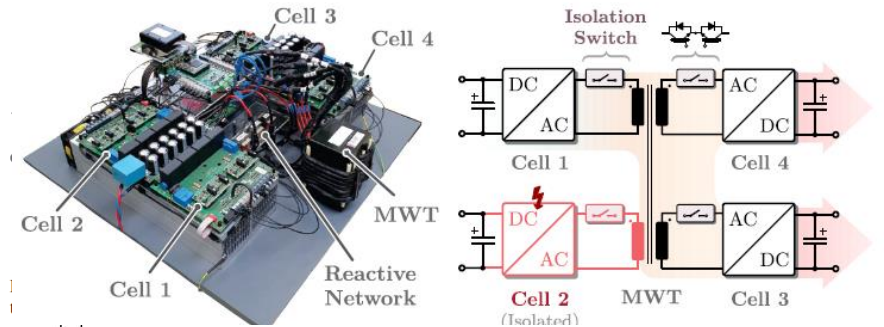
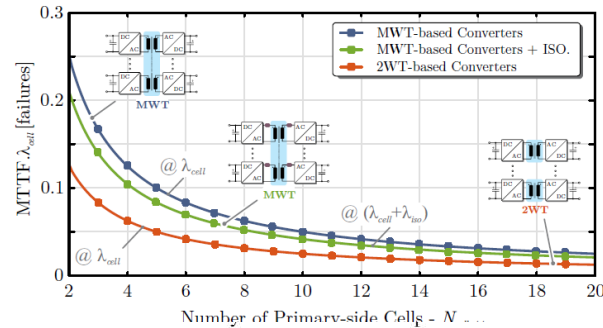
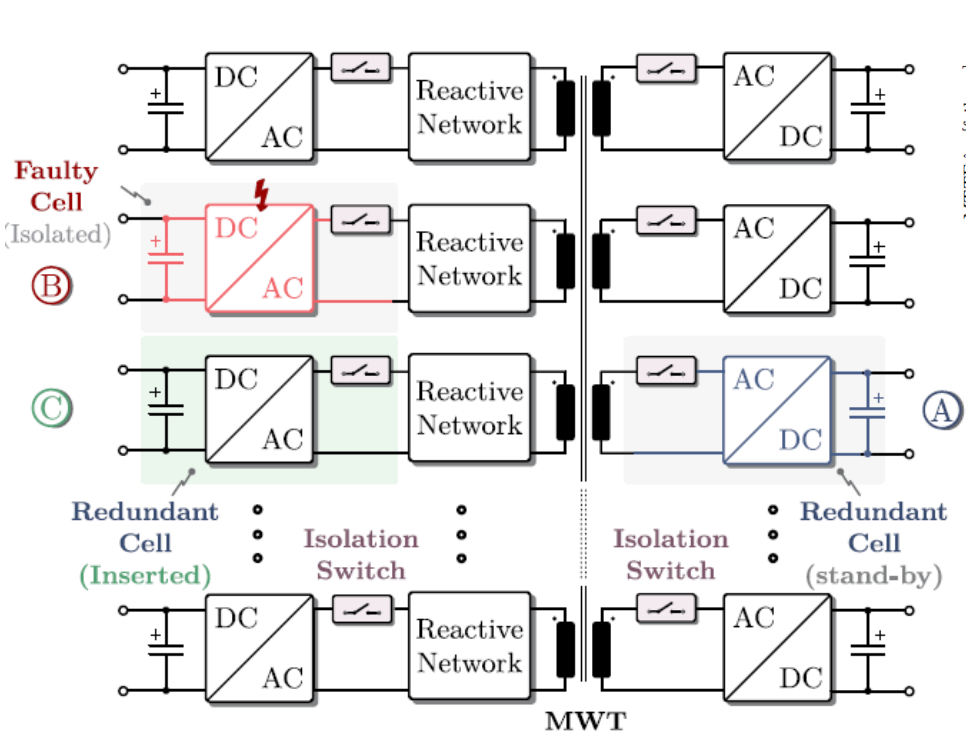
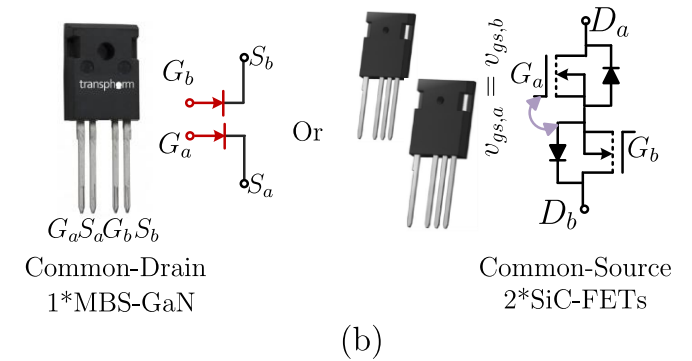
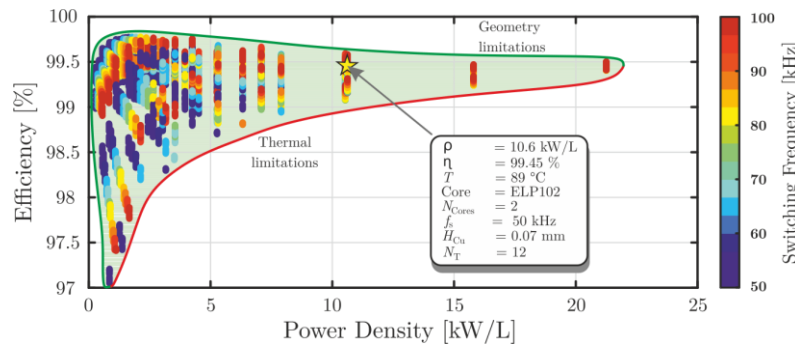
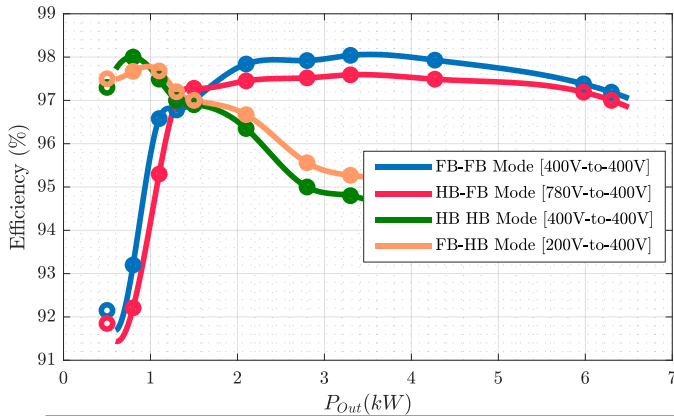
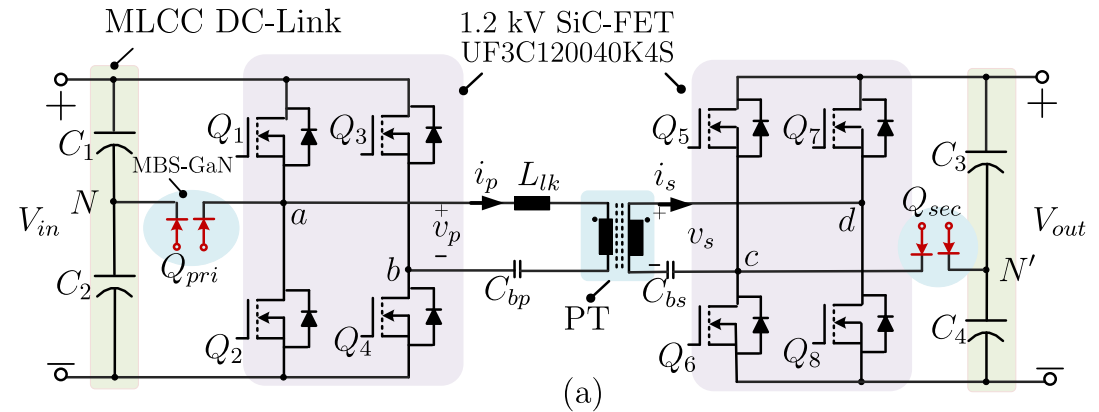


Figure 11. Experimental results of the SQAB under a fault at the cell 1 and cell 3 and the posterior reconfiguration to the resulting DC-DC converter: after the cell 1 be disconnected, the SQAB is reconfigured to a TAB and then when the cell 3 is disconnected the converter is reconfigured to a DAB.

BIDIRECTIONAL DEVICES IN DAB CONVERTER

Application in Reconfigurable DAB Converter

- A **Fault Tolerant-Based DAB** converter with MBS-GaN.
- Four different circuit possibilities for a **wide range of voltage conversion gain**, 200 to 800 V input and 400 V output.
- Maintaining the high efficiency of the DAB (>97%) even at **low power** with **ZVS** action.
- **Highly Efficient/High power density** design using **MBS-GaN** and **Planar Transformer**.



(a) The proposed reconfigurable DAB converter, and (b) realization of a four-quadrant device using MBS-GaN or SiC-FETs.

R. Barzegarkhoo, F. Groot, A. Sengupta and M. Liserre, " A 6.6 kW Highly Efficient Reconfigurable Dual Active Bridge Converter Designed Using Planar Transformer, SiC-FETs and Monolithic Bidirectional Devices," APEC 2025.

BIDIRECTIONAL DEVICES IN DAB CONVERTER

Application in Reconfigurable DAB Converter

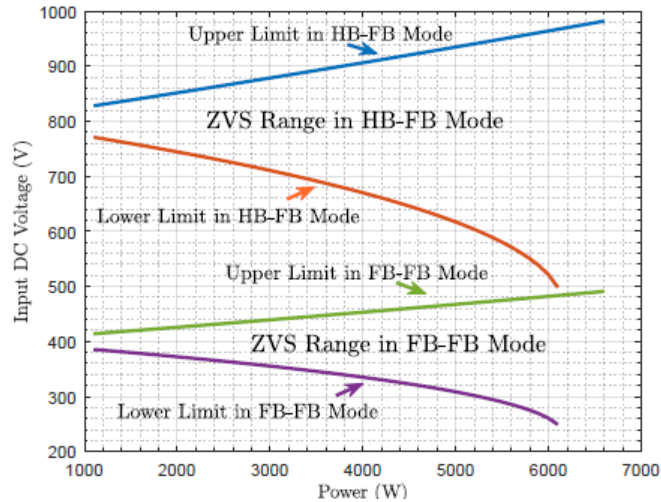
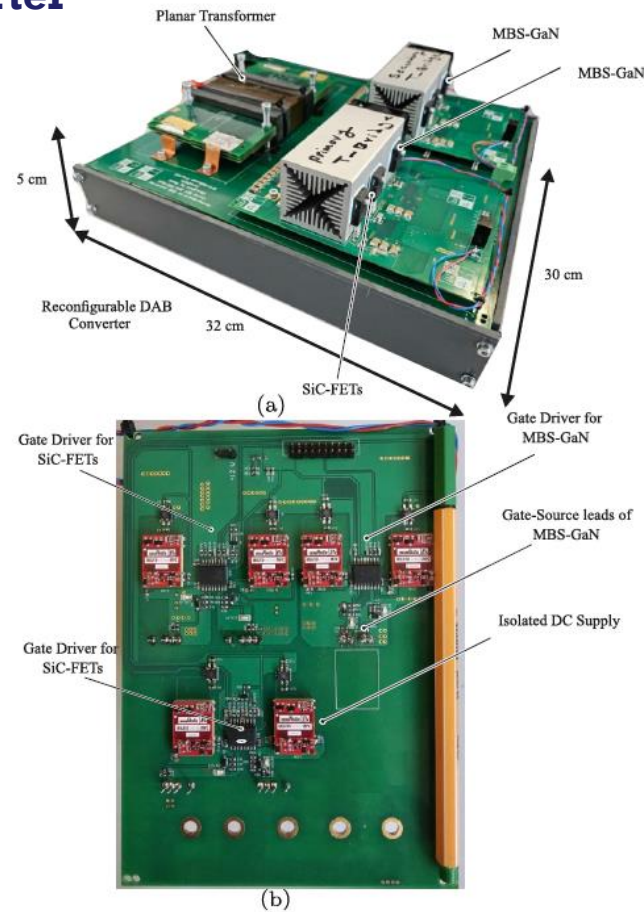
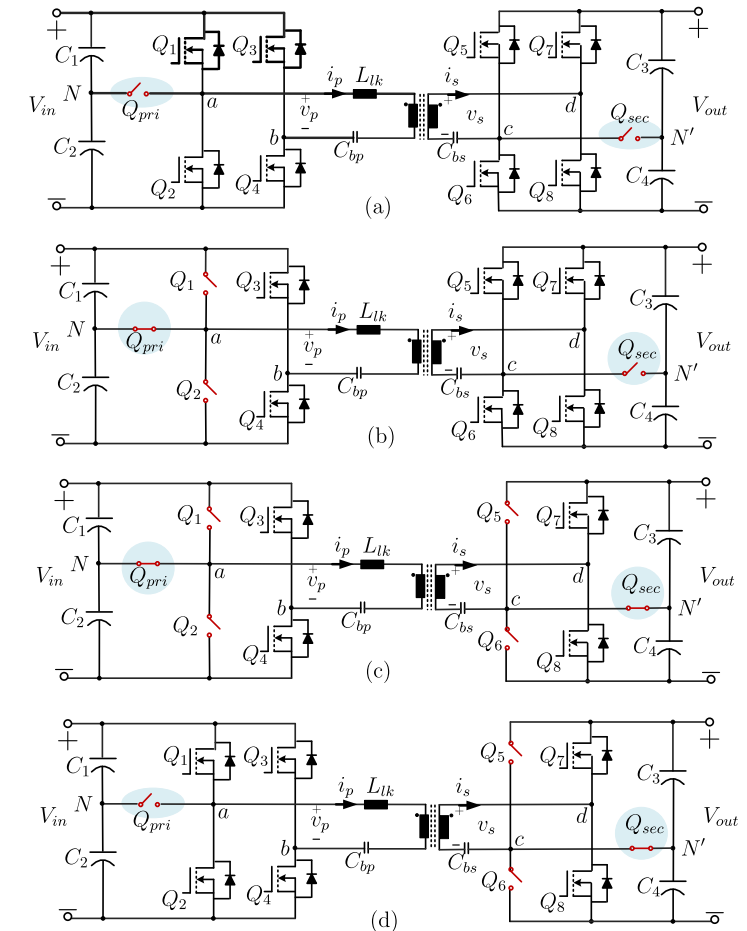


TABLE I: Main parameters used for the experimental prototype

Element	Type and Description
Switching Frequency/Rated Power	50 kHz/ 6.6 kW
SiC-FETs	1.2 kV/UF3C120040K4S
MBS-GaN	±650V/TP65F060WS
MLCCs	10x220nF/GRM55DR7LW224KW1L
V_{in}/V_{out}	200–800V/400V
Microprocessor	DSP-TMS320F28379D
C_{bp}/C_{bs}	8x470nF/2220Y1K00474KXS2
L_{lk}	25uH/E42/21/20 N87
Gate Drivers	UCC21520
Isolated dc/dc ICs	MGJ1D051505MPC
Sensors	AMC3330



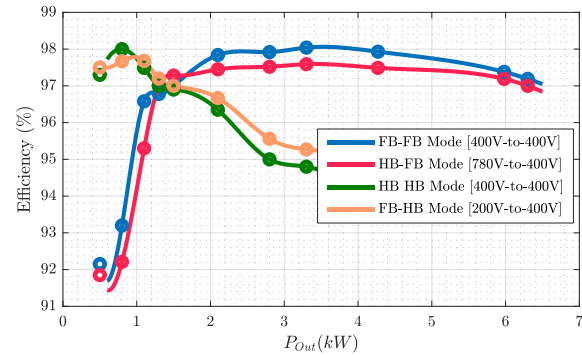
6.6 kW fabricated prototype for the proposed reconfigurable DAB converter



The proposed reconfigurable DAB converter, and its operation mode based on (a) FB-FB, (b) HB-FB, (c) HB-HB, and (d) FB-HB configurations.

BIDIRECTIONAL DEVICES IN DAB CONVERTER

Application in Reconfigurable DAB Converter



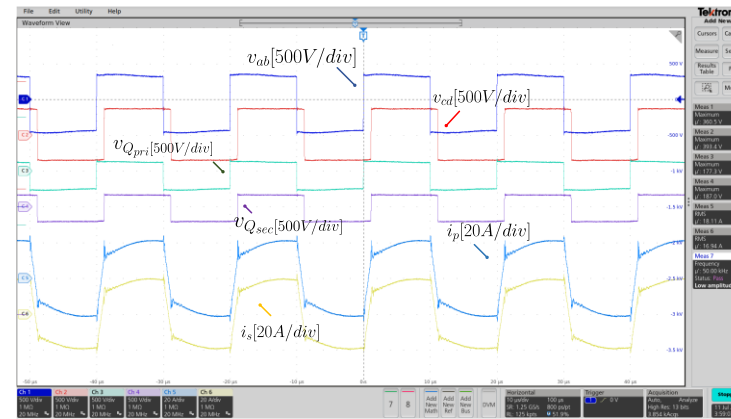
(b)

(c)

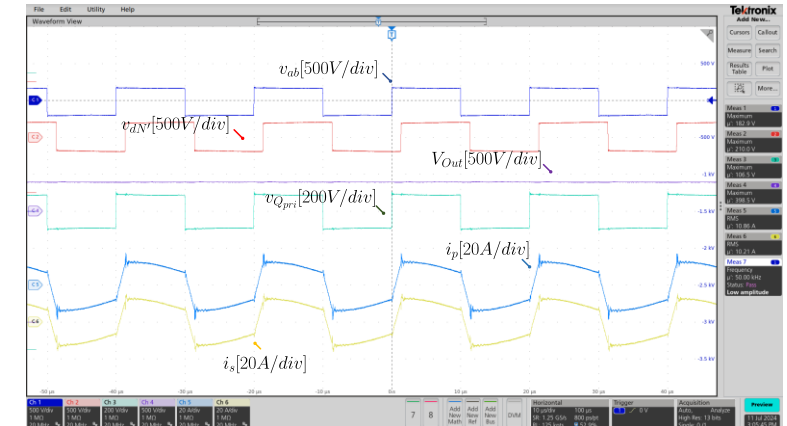


(d)

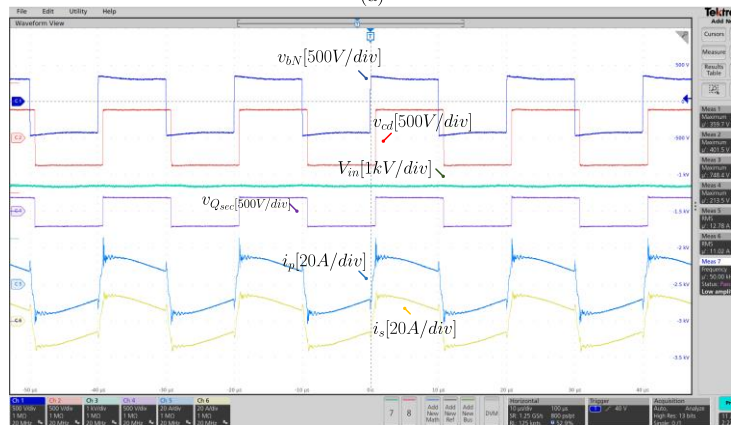
(e)



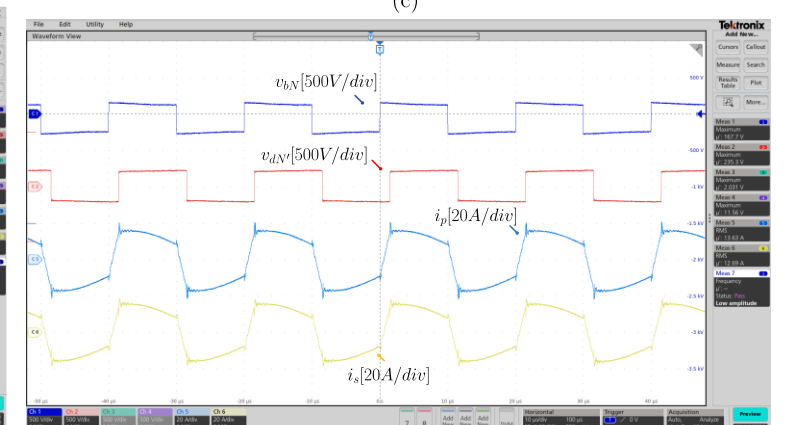
(a)



(c)



(b)

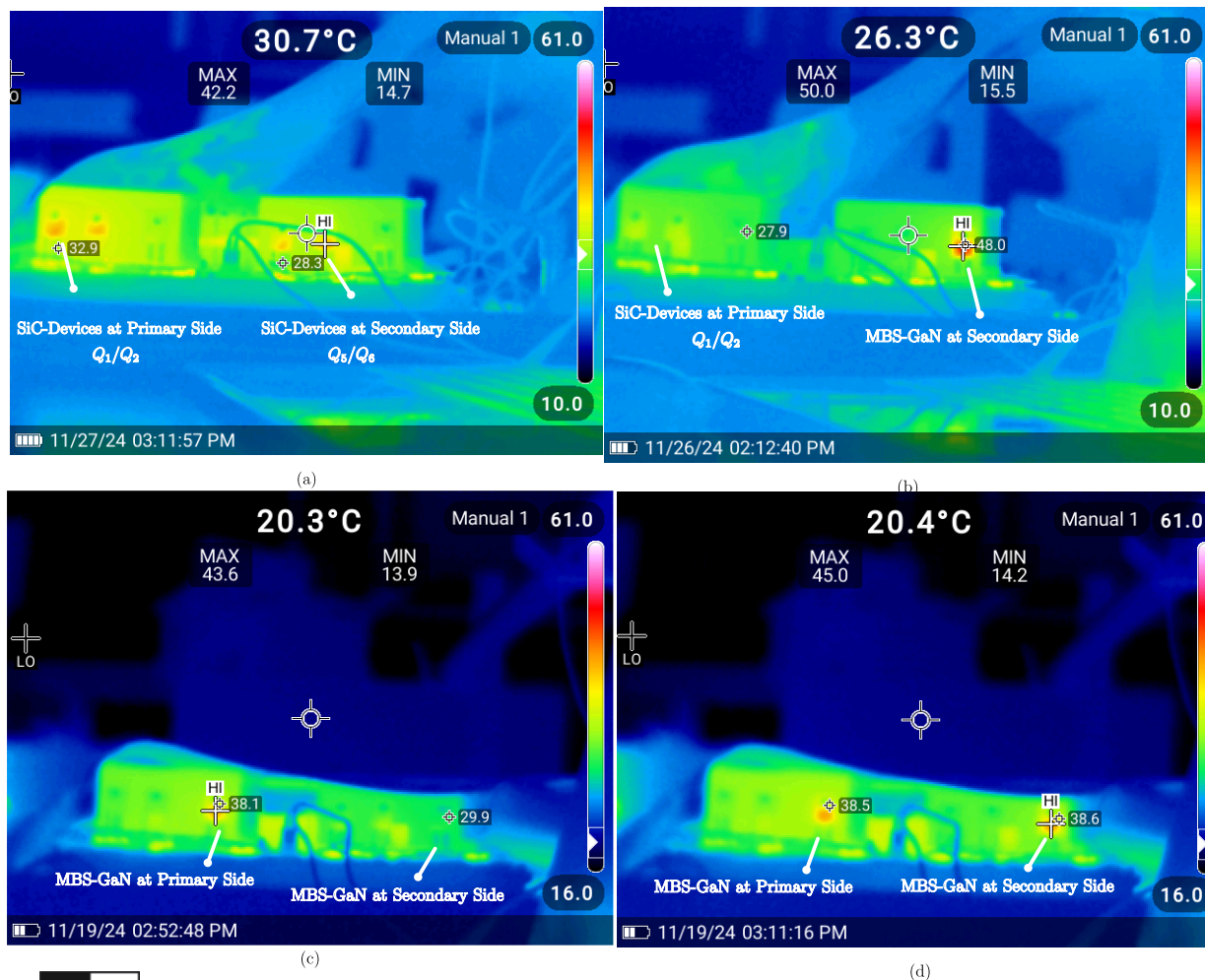


(d)

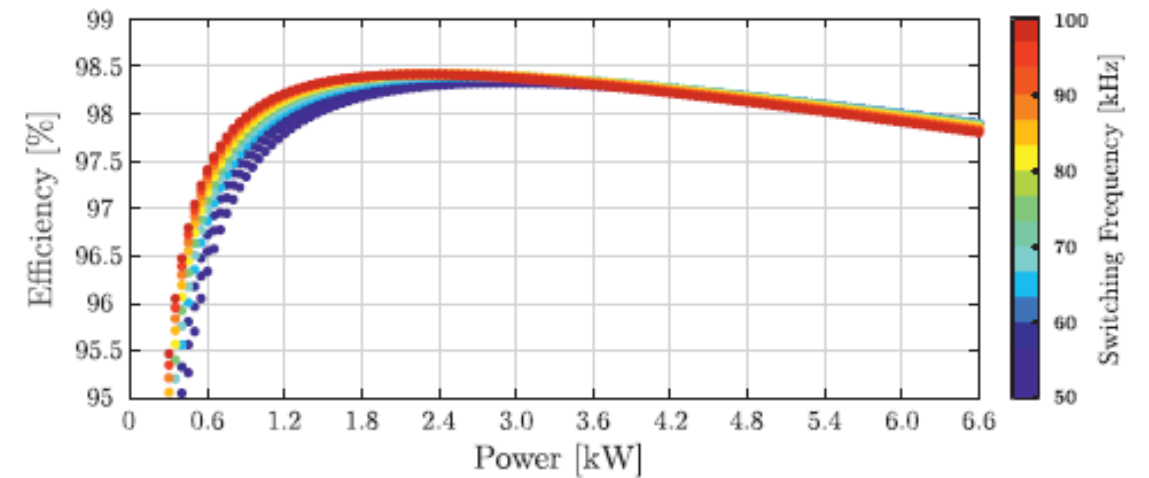
Experimental results of the proposed reconfigurable DAB converter at (a) FB-FB Mode [6.3 kW/400 V to 400 V], (b) HB-FB Mode [4.4 kW/760 V to 400 V], (c) FB-HB Mode [2 kW/200 V to 400 V], and (d) HB-HB Mode [2.5 kW/400 V to 400 V].

BIDIRECTIONAL DEVICES IN DAB CONVERTER

► Application in Reconfigurable DAB Converter



MBS-GaN devices temperature in primary and secondary side of the PT after five minutes continuous running at (a) FB-FB Mode [6,6 kW/400 V- to 400 V], (b) FB-HB Mode [2,5 kW/200 V to 400 V], (c) HB-FB mode [3.8 kW/770 V to 400 V], and (d) HB-HB mode [2 kW/400 V to 430 V]



Pareto-Front result for the entire reconfigurable DAB converter at the FB-FB mode considering the switching/conduction losses of the devices as well as the core and winding losses of the designed PT and the leakage inductor.

- ❑ Bidirectional power devices are constructed based on **back-to-back connection of two or four devices in existing topologies to block** a stress voltage in **both polarity** or to conduct a current in **both direction**.
- ❑ Large ON-State resistance/parasitic capacitance, large footprint area and power layout consideration are their main shortcomings (e.g., in comparison to SiC MOSFET, conduction losses increase **4 times** when discrete GaN-HEMT is employed in a bidirectional fashion.)
- ❑ **Monolithic Bidirectional Switch (MBS)** using **Lateral GaN-on Si** design or **Cascode Technique** with a common drain can surpass this shortcoming by offering lower on-state resistance.
- ❑ One of its main applications is its utilization as an isolation switch in SSCBs. Due to lower expected on-state resistance of MBS and fast response of GaN-HEMTs, it is expected to **trip an SSCB within less than 200 ns (the obtained value using SiC-based SSCB)**.
- ❑ **MBS-GaN** can also be incorporated into the multiwinding transformer (**MWT**)-based multi-port DAB converters. Based on the analysis done on SSCBs, a fault detection procedure got developed for wide-band-gap device. Hence, the results for **fault tolerant MWT-DAB** with **both discrete GaN-HEMTs and SiC-FETs** got reported in different working scenarios.
- ❑ Thanks to smaller footprint area compared to discrete-based bidirectional device and due to expected lower conduction losses, a reconfigurable DAB converter with **MBS-GaN** got developed. This could help to achieve four-different configurations. Compared to conventional DAB converters, the proposed structure can achieve **>97%** efficiency even **at lower power** and for **wide range of voltage conversion gain**. The power ratio of the designed prototype is **6.6 kW/50 kHz**.
- ❑ Even though such appealing opportunities, the **short circuit ruggedness of MBS-GaN** is expected to be poorer than **discrete GaN-HEMTs (less than 1 μ S)**. This needs a careful thermal modeling.
- ❑ MBS-GaN needs **two gate drivers**, while it is expected to see a **reverse recovery loss in its cascode version**. DPT can be performed to distinguish the gate driver dependency to the source-to-source voltage of the device and the switching loss behavior.



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THANK YOU!

